

Notice of References Cited	Application/Control No. 10/799,895	Applicant(s)/Patent Under Reexamination MADRID, RUBEN	
	Examiner Edward Wojciechowicz	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2002/0074147	06-2002	Tan et al.	174/52.4
X	B	US-2002/0050912	05-2002	Shrier et al.	338/21
X	C	US-5,892,271	04-1999	Takeda et al.	257/668
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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